Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/798,112	RAWLE, STEPHEN	
Examiner	Art Unit	
Hwei-Siu C. Payer	3724	

	SEAR	CHED					
Class	Subclass	Date	Examiner				
030	050	updated on 7-27-06	Vager				
		7-27-06					
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMF
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